



FCC RF Test Report

Product Name: LTE USB Rotator

Model Number: E3276s-151

**Report No: SYBH(Z-RF)025082012-2002
FCC ID:QISE3276S-151**

Reliability Laboratory of Huawei Technologies Co., Ltd.

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Notice

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2. The laboratory has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements. The site recognition number is 97456.
3. The laboratory has been listed by industry Canada to perform electromagnetic emission measurement. The site recognition number is 6369A-2.
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Applicant:	Huawei Technologies Co., Ltd.
Address:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Date of Receipt Test Item:	Aug., 27, 2012
Start Date of Test:	Aug., 28, 2012
End Date of Test:	Sep., 07, 2012
Test Result:	Pass

Approved By Senior Engineer Sep., 10, 2012 Dai Linjun
 Date Name Signature

Reviewed By Sep., 10, 2012 Cousy Xu
 Date Name Signature

Operated By Sep., 10, 2012 Huang Qiuliang
 Date Name Signature

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1 General Information

1.1 Applied Standard	
Applied Rules:	47 CFR FCC Part 2:2011, Subpart J 47 CFR FCC Part 24:2011, Subpart E ANSI/TIA 603C:2004
1.2 Test Location	
Test Location 1:	Reliability Laboratory of Huawei Technologies Co., Ltd.
Address:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
1.3 Test Environmental Condition	
Ambient Temperature:	20 – 25 °C
Ambient Relative Humidity:	45 – 55 %
Atmospheric Pressure:	101 kPa



2 Summary

Table 1 Summary of results

Test Case	FCC Part No.	Requirements	Result
PCS Band			
Transmitter Output Power	2.1046 & 24.232	Peak EIRP not exceed 2 W Peak-to-Average Ratio not exceed 13dB	Pass
Modulation Characteristics	2.104	Digital modulation	Pass
Occupied Bandwidth	2.104	(Not specified)	Pass
Band Edges Compliance	2.1051 & 24.238	Below -13 dBm/1%*EBW, in 1 MHz range	Pass
Spurious Emission at Antenna Terminals	2.1051 & 24.238	Below -13 dBm/1 kHz, 9 kHz to 150 kHz Below -13 dBm/10 kHz, 150 kHz to 30 MHz Below -13 dBm/1 MHz, 30 MHz to 10 th harmonics	Pass
Field Strength of Spurious Radiation	2.1053 & 24.238	Below -13 dBm/1 MHz	Pass
Frequency Stability	2.1055 & 24.235	Stay within the authorized frequency block	Pass



3 Product Description

3.1 Product Information

3.1.1 General Description

E3276s-151 LTE USB Rotator is subscriber equipment in the LTE/DC-HSPA+/HSUPA/HSDPA/WCDMA/EDGE/GPRS/GSM system. LTE supports Band III、 IV、 VII、 XX, DC-HSPA+/HSUPA/HSDPA/WCDMA supports Band I、 II、 IV、 VII, EDGE/GPRS/GSM Supports GSM 850、 900、 1800、 1900,but only GSM 1900and Band II test date included in this report.E3276s-151 implement such functions as RF signal receiving/transmitting, LTE/DC-HSPA+/HSUPA/HSDPA/WCDMA and EDGE/GPRS/GSM protocol processing, data service etc. Externally it provides USB interface (to connect to the notebook etc.), USIM card interface and Micro SD card interface. E3276s-151 has an internal antenna as default.

3.1.2 Board Information

Table 2 Board Information

LTE USB Rotator		
E3276s-151		
Board and Module		
Description	Hardware Version	Serial Number
MAIN BOARD	CH1E3276SM	A2F01A9251800157

4 Test Description

4.1 Supported Frequency Range

Characteristics	Description
Downlink	1930 to 1990 MHz
Uplink	1850 to 1910 MHz

4.2 Transmitter / Receiver Characteristics

Characteristics	Description
System Type	GSM UMTS
TX Output Power (per Antenna Port)	GSM system: Power class 1; UMTS system: Power class 3
Channel Spacing(s) / Bandwidth(s)	GSM system: 200 kHz UMTS system: 5 MHz
Designation of Emissions	GSM system: 247KGXW (GMSK modulation), 257KG7W (8PSK modulation) UMTS system: 4M17F9W



4.3 Antenna Gain

Antenna Gain(dBi)	3.6
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4.4 Power Supply

Specification	Description
Power Supply Type	Directly Connected to DC Supply
Input to EUT (DC power)	DC Voltage Nominal: $\text{---} 5 \text{ V}$

5 General Test Conditions / Configurations

5.1 RF Channels under Test

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
TM1/TM2	TX	Channel 512	Channel 661	Channel 810
		1850.2MHz	1880.0MHz	1909.8MHz
	RX	Channel 512	Channel 661	Channel 810
		1930.2 MHz	1960.0 MHz	1989.8 MHz
TM3/TM4/TM5	TX	Channel 9262	Channel9400	Channel9538
		1852.4MHz	1880.0MHz	1907.6MHz
	RX	Channel 9662	Channel 9800	Channel 9938
		1932.4 MHz	1960.0 MHz	1987.6 MHz

5.2 Test Modes

Test Mode	Test Modes Description
TM1	GSM/GPRS, GMSK modulation
TM2	EDGE, 8PSK modulation
TM3	WCDMA, QPSK modulation
TM4	HSDPA, QPSK modulation
TM5	HSUPA, QPSK modulation

Note:

HSPA+ implementation of this device, 16QAM is not used for uplink. The uplink Category and release number is same as HSUPA, RF test is evaluation is not required.

DC-HSDPA implementation of this device, the uplink parameters are the same as HSDPA. No additional channels and modulations (16 QAM, and 64 QAM) are supported in uplink. The difference is only in the downlink parameters. HSDPA settings were used on uplink.

5.3 Test Environment

Environment Parameter	Selected Values During Tests	
Relative Humidity	Ambient	
Temperature	TN	Ambient
Voltage	VL	4.75V
	VN	5V



Environment Parameter	Selected Values During Tests	
	VH	5.25V

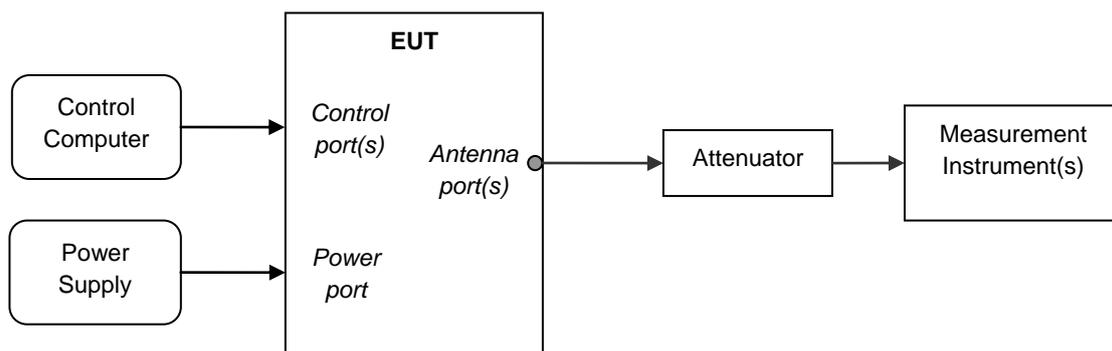
NOTE: VL= lower extreme test voltage
VN= nominal voltage
VH= upper extreme test voltage
TN= normal temperature

5.4 Test Setup

5.4.1 General Test Setup Configurations

Configuration	Description
Test Antenna Ports	Until otherwise declared, all TX tests are ONLY performed at the main Transmitter antenna port (e.g. TRXA, TXA and so on) of the EUT, and all RX tests are ONLY performed at the main Receiver antenna port (e.g. TRXA, RXA and so on) of the EUT.
Multiple RF Sources	Other than the tested RF source of the EUT, other RF source(s) are disabled or shutdown during measurements.

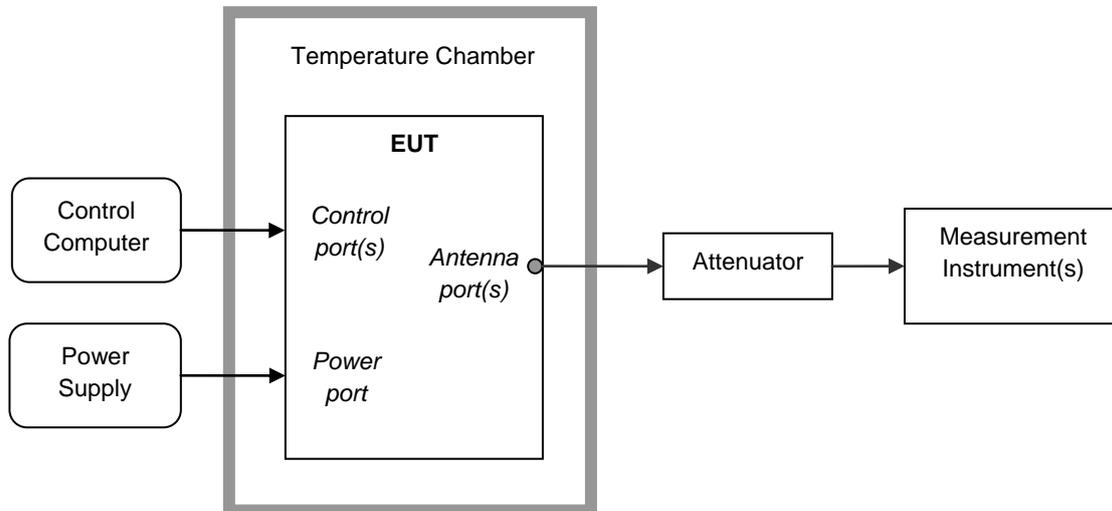
5.4.2 Test Setup 1



Note

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA and LTE signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

5.4.3 Test Setup 2



5.4.4 Test Setup 3

NOTE1: Effective radiated power (ERP) or Effective Isotropic radiated power (EIRP) refers to the EUT radiation power output, assuming all emissions are radiated from half-wave dipole antennas or horn antennas.

NOTE2: The EUT was set on insulator 80cm above the Ground Plane. The setup and test methods were according to ANSI-TIA-603C 2004. The measurements were carried through with a Rohde and Schwarz Test Receiver and control software.

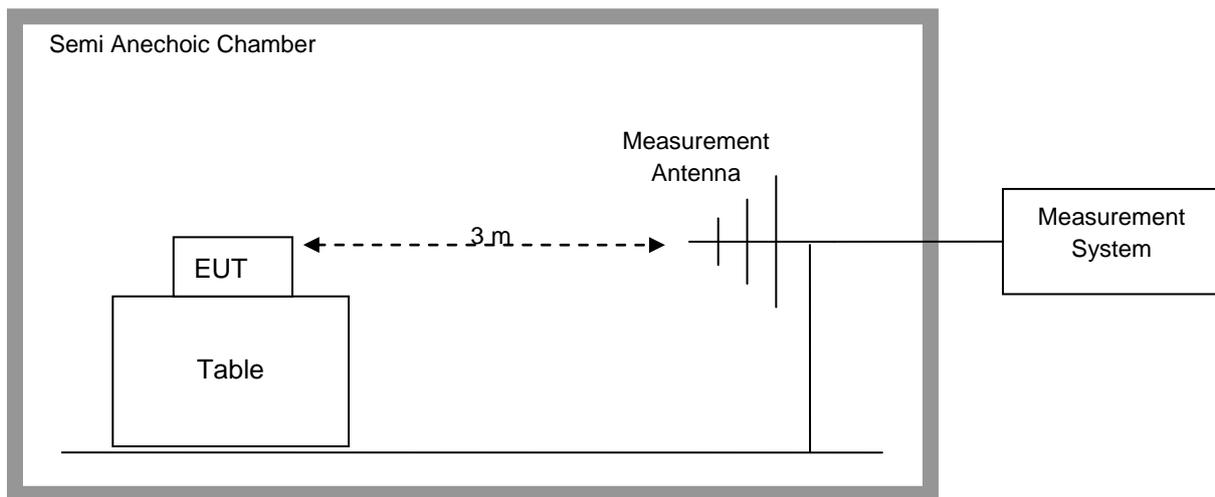
Step 1: Pre-test to find the Maximum ERP or EIRP

1. Connect the test system according to the following figure. EUT is running for 30 minutes before test, and measurement instruments are warming-up for 30 minutes.
2. Set up communication link between Universal radio communication tester and EUT, set EUT working frequency, and control EUT to transmit at maximum power.
3. Set the center frequency of the signal analyzer or receiver to the EUT's operating frequency, the RBW is equal to the emission bandwidth of the signal. Set RMS detector for the test, and the span is

equal to 2 times of emission bandwidth, the other settings should remain automatic. Normally, the height range of antenna was 1m to 4m, the azimuth range of turntable was 0°to 360°. The receiver antenna has two polarizations V and H. A portable or small unlicensed wireless device shall be placed on a non-metallic test fixture or other non-metallic support during testing. The supporting fixture shall permit orientation of the EUT in each of three orthogonal (x, y, z) axis positions such that emissions from the EUT are maximized. Measure the EUT maximum RF power and record the result.

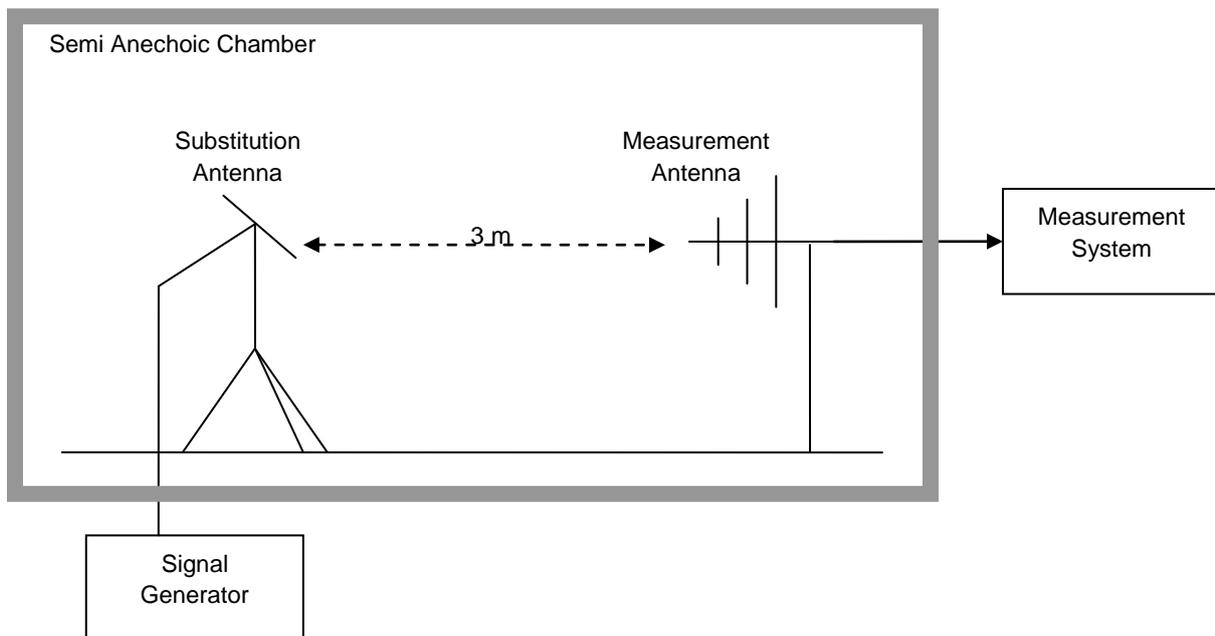
4. Changing EUT working frequency and measuring the RF power at channel L, M, H respectively.

Complete the test data.



Step 2: Substitution method to verify the maximum ERP or EIRP

1. Measurement setup is according to the following figure. EUT was substituted by antenna, and the polarization is identical with the test antenna; the signal generator was connected to the substitution antenna.
2. The radiated output power, measured by signal analyzer set, is the same as recorded in above item 5). Then this power level is matched by a signal from a calibrated signal generator which is substituted for EUT. The power supplied by the generator is then equal to the ERP or EIRP after corrected by the antenna gain and cable loss.



5.5 Test Conditions

Test Case	Test Conditions	
Transmitter Output Power	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1 & Test Setup 3
	Detector	RMS
	RF Channels (TX)	L, M, H
	Test Mode	TM1/TM2/TM3/TM4TM5
Modulation Characteristics	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	RF Channels (TX)	M
	Test Mode	TM1/TM2/TM3
Occupied Bandwidth	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	PK
	RF Channels (TX)	L, M, H
	Test Mode	TM1/TM2/TM3
Band Edges Compliance	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	RMS
	RF Channels (TX)	L, H
	Test Mode	TM1/TM2/TM3
Spurious Emission at Antenna Terminals	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	PK
	RF Channels (TX)	L, M,H
	Test Mode	TM1/TM2/TM3
Field Strength of Spurious Radiation	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 3
	Detector	PK
	RF Channels (TX)	M
	Test Mode	TM1/TM2/TM3/TM4TM5
Frequency Stability	Test Configuration	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage; (2) VL VN VH Voltage at Ambient Temperature.
	Test Setup	Test Setup 2
	RF Channels (TX)	M
	Test Mode	TM1/TM2/TM3

6 Main Test Instruments

Table 3 Main Test Equipments

Equipment Description	Manufacturer	Model	Serial Number	Calibrated until
Power supply	KEITHLEY	2303	1288003	Sep.27,2012
Universal Radio Communication Tester	R&S	CMU200	117341	Jan.12.2013
Universal Radio Communication Tester	Agilent	E5515C	MY50260239	Aug.31,2013
Spectrum Analyzer	Agilent	E4440A	MY49420179	Jul.17,2013
Signal Analyzer	R&S	FSQ31	200021	Sep.27,2012
Temperature Chamber	WEISS	WKL64	24600294	Feb.13,2013
Signal generator	Agilent	E8257D	MY49281095	Jul.09.2013
Spectrum analyzer	R&S	FSU3	200474	Mar., 05, 2013
Spectrum analyzer	R&S	FSU43	100144	Mar., 05, 2013
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100304	Apr., 05, 2013
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100391	Apr., 05, 2013
Trilog Broadband Antenna (30M~3GHz)	SCHWARZBECK	VULB 9163	9163-521	Jul., 07, 2013
Pyramidal Horn Antenna(26GHz-40GHz)	ETS-Lindgren	3160-10	00123940	Feb., 27, 2013
Pyramidal Horn Antenna(18GHz-26.5GHz)	ETS-Lindgren	3160-09	00125912	Feb.,27, 2013

NOTE: All the test equipment are calibrated once a year.

7 Test Results

No.	Test Item	Test Result
1	Transmitter Output Power	Appendix A
2	Modulation Characteristics	Appendix B
3	Occupied Bandwidth	Appendix C
4	Band Edges Compliance	Appendix D
5	Spurious Emission at Antenna Terminals	Appendix E
6	Radiated Spurious Emissions	Appendix F
7	Frequency Stability	Appendix G
8	Photos of Radiated Spurious Emissions	Appendix H

NOTE: There is no test data in Appendix H, only Photos of Test Setup for Field Strength of Spurious Radiation.

8 Measurement Uncertainty

For a 95% confidence level (k=2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item		Extended Uncertainty
Transmitter Output Power	Power (dBm)	U =0.39 dB
Occupied Bandwidth	Magnitude (%)	U=0.2%
Band Edge Compliance	Disturbance Power (dBm)	U=2.0 dB
Conducted Spurious Emissions	Disturbance Power (dBm)	U=2.0 dB
Field Strength of Spurious Radiation	ERP (dBm)	U=4.6 dB (30 MHz – 1GHz) U=3.0 dB (above 1 GHz)
Frequency Stability	Frequency Accuracy (ppm)	U=0.21 ppm

-----The END-----